Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination ZHANG ET AL. | Examiner | Art Unit | Pierre-Michel Bataille | 2186 | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0149716	07-2005	Nair et al.	713/001
*	В	US-2005/0108474	05-2005	Zhang et al.	711/114
*	С	US-2005/0071619	03-2005	Chu et al.	713/002
*	D	US-2005/0097310	05-2005	Chu et al.	713/002
*	Е	US-2003/0187997	10-2003	Alexis, Alan Previn	709/229
*	F	US-6,684,327	01-2004	Anand et al.	713/2
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	EP1283464A	03-2006	Europe	Lecarpentier et al	G06F 9/455
*	0	JP20020169694	08-2001	Japan	Subramanian, H C	G06F 9/445
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	U								
•	V								
	w								
	x								

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.